

# NCE30H32WD-VB Datasheet N-Channel 30 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	30
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 V$	0.0014
$R_{DS(on)}(\Omega)$ at $V_{GS} = 4.5 V$	0.0016
I <sub>D</sub> (A)	260
Configuration	Single

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET

GC

• Package with Low Thermal Resistance

D

- 100 %  $\rm R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC







#### N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unles	s otherwise noted	)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	30	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
Continuous Drain Current	T <sub>C</sub> = 25 °C	- I <sub>D</sub> -	260	
	T <sub>C</sub> = 125 °C		120 <sup>a</sup>	
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	120	А
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	680	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	82	
Single Pulse Avalanche Energy		E <sub>AS</sub>	336	mJ
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	D	375	W
	T <sub>C</sub> = 125 °C	P <sub>D</sub>	125	vv
Operating Junction and Storage Temperature Range	ge	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount <sup>c</sup>	R <sub>thJA</sub>	40	°C/W
Junction-to-Case (Drain)		R <sub>thJC</sub>	0.4	0/10

#### Notes

a. Package limited.

- b. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- c. When mounted on 1" square PCB (FR-4 material).
- d. Parametric verification ongoing.

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PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT	
Static	1			•		•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 250 μA	30	-	-	V	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	- V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	1.5	2.0	2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> =	0 V, $V_{GS} = \pm 20 V$	-	-	± 100	nA	
		$V_{GS} = 0 V$	V <sub>DS</sub> = 30 V	-	-	1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	$V_{DS} = 30 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$	-	-	50	μA	
		$V_{GS} = 0 V$	V <sub>DS</sub> = 30 V, T <sub>J</sub> = 175 °C	-	-	250	1	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>GS</sub> = 10 V	$V_{DS} \ge 5 V$	120	-	-	Α	
		$V_{GS} = 10 V$	I <sub>D</sub> = 30 A	-	0.0014	-		
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A, T <sub>J</sub> = 125 °C	-	0.0023	-		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A, T <sub>J</sub> = 175 °C	-	0.0028	-	Ω	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 20 A	-	0.0016	-		
Forward Transconductance <sup>b</sup>	<b>g</b> fs	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A		-	190	-	S	
Dynamic <sup>b</sup>					•			
Input Capacitance	C <sub>iss</sub>			-	12 484	15 605		
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = 15 V, f = 1 MHz	-	2204	2755	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	860	1075	1	
Total Gate Charge <sup>c</sup>	Qg			-	179	270		
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	$V_{GS} = 10 V$	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 120 \text{ A}$	-	34	-	nC	
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			-	21	-	1	
Gate Resistance	R <sub>g</sub>		f = 1 MHz	0.59	1.19	1.79	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			-	18	27		
Rise Time <sup>c</sup>	t <sub>r</sub>	- V=	= 15 V, R <sub>I</sub> = 0.3 Ω	-	11	17	1	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>		$V_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$	-	64	96	ns	
Fall Time <sup>c</sup>	t <sub>f</sub>	1	-	11	17	1		
Source-Drain Diode Ratings and Char	acteristics <sup>b</sup>	•						
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	-	480	A	
Forward Voltage	V <sub>SD</sub>	IF =	60 A, V <sub>GS</sub> = 0 V	-	0.81	1.5	V	

Notes

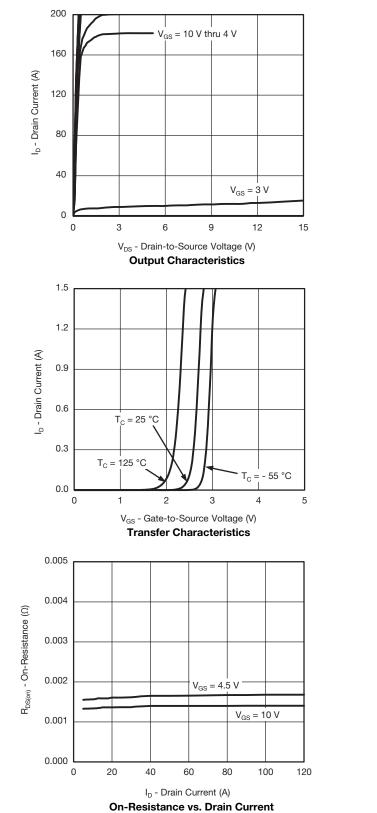
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

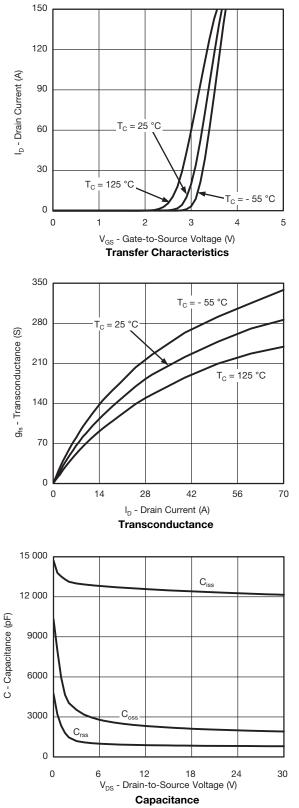
c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



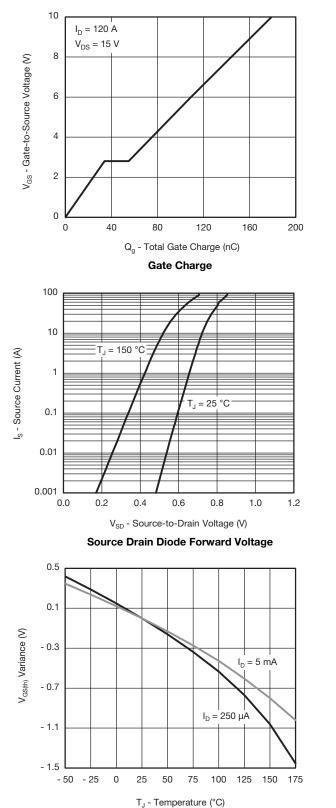
服务热线:400-655-8788



V<sub>GS</sub> = 10 V

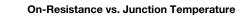
 $V_{GS} = 4.5 V$ 

150 175



Threshold Voltage

## **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



T<sub>J</sub> - Junction Temperature (°C)

2.0

1.7

1.4

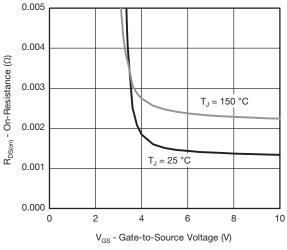
1.1

0.8

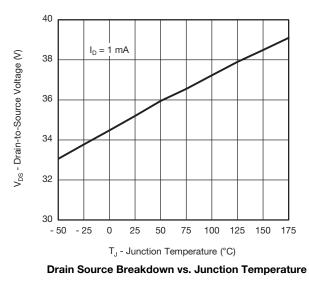
0.5

- 50 - 25 0 25 50 75 100 125

R<sub>DS(on)</sub> - On-Resistance (Normalized) I<sub>D</sub> = 30 Å



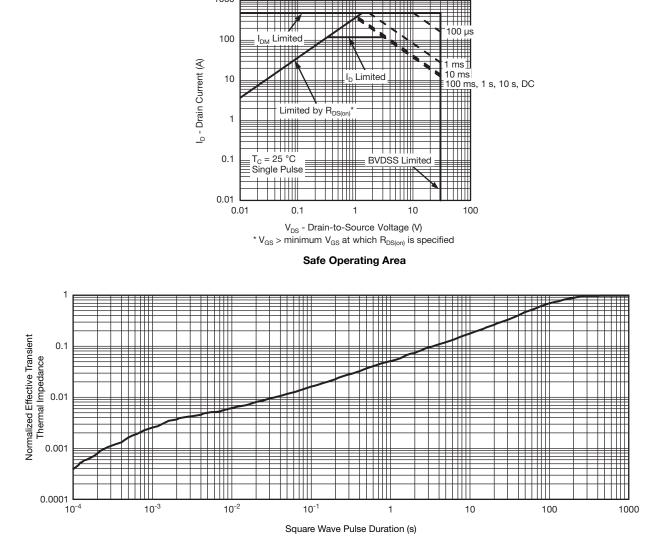






## THERMAL RATINGS (T<sub>A</sub> = 25 °C, unless otherwise noted)

1000

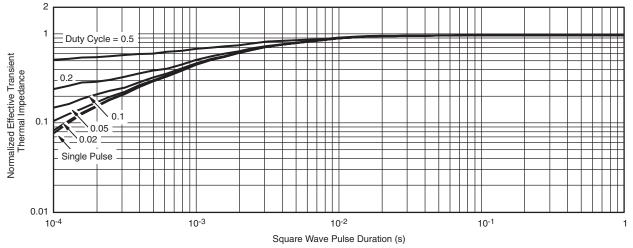


Normalized Thermal Transient Impedance, Junction-to-Ambient

## NCE30H32WD-VB



### THERMAL RATINGS (T<sub>A</sub> = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

#### Note

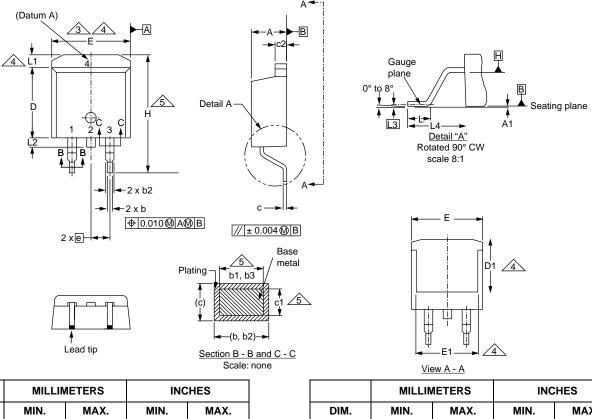
The characteristics shown in the two graphs •

- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



#### **TO-263AB (HIGH VOLTAGE)**



 	_		
DIM.	DIM. MIN.	DIM. MIN. MAX.	DIM. MIN. MAX. MIN.
D1	D1 6.86	D1 6.86 -	D1 6.86 - 0.270
E	E 9.65	E 9.65 10.67	E 9.65 10.67 0.380
E1	E1 6.22	E1 6.22 -	E1 6.22 - 0.245
e	e 2.54	e 2.54 BSC	e 2.54 BSC 0.100
Н	H 14.61	H 14.61 15.88	H 14.61 15.88 0.575
L	L 1.78	L 1.78 2.79	L 1.78 2.79 0.070
L1	L1 -	L1 - 1.65	L1 - 1.65 -
L2	L2 -	L2 - 1.78	L2 - 1.78 -
L3	L3 0.25	L3 0.25 BSC	L3 0.25 BSC 0.010
L4	L4 4.78	L4 4.78 5.28	L4 4.78 5.28 0.188

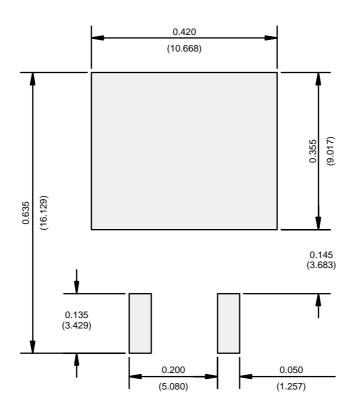
#### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



# **RECOMMENDED MINIMUM PADS FOR D PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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